



**AO4490**

**N-Channel Enhancement Mode Field Effect Transistor**



#### General Description

The AO4490/L uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V, while retaining a 20V  $V_{GS(MAX)}$  rating. It is ESD protected. This device is suitable for use as a load switch and general purpose applications. *AO4490 and AO4490L are electrically identical.*

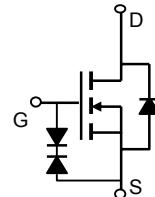
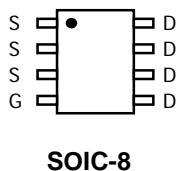
-RoHS Compliant  
-AO4490L is Halogen Free

#### Features

$V_{DS}$  (V) = 30V  
 $I_D$  = 16A ( $V_{GS}$  = 10V)  
 $R_{DS(ON)} < 7.2\text{m}\Omega$  ( $V_{GS}$  = 10V)  
 $R_{DS(ON)} < 10\text{m}\Omega$  ( $V_{GS}$  = 4.5V)

ESD protected

**UIS Tested!**  
*Rg, Ciss, Coss, Crss Tested*



#### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter   | Symbol         | Maximum    | Units |
|---|----------------|------------|-------|
| Drain-Source Voltage                                      | $V_{DS}$       | 30         | V     |
| Gate-Source Voltage                                       | $V_{GS}$       | $\pm 20$   | V     |
| Continuous Drain Current <sup>A</sup> F                   | $I_D$          | 16         | A     |
| $T_A=70^\circ\text{C}$                                    |                | 13         |       |
| Pulsed Drain Current <sup>B</sup>                         | $I_{DM}$       | 120        |       |
| Avalanche Current <sup>G</sup>                            | $I_{AR}$       | 30         | A     |
| Repetitive avalanche energy $L=0.3\text{mH}$ <sup>G</sup> | $E_{AR}$       | 135        | mJ    |
| Power Dissipation   | $P_D$          | 2.8        | W     |
| $T_A=70^\circ\text{C}$                                    |                | 1.8        |       |
| Junction and Storage Temperature Range                    | $T_J, T_{STG}$ | -55 to 150 | °C    |

#### Thermal Characteristics

| Parameter                                | Symbol          | Typ | Max | Units |
|--|-----------------|-----|-----|-------|
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{\theta JA}$ | 32  | 45  | °C/W  |
| Steady-State                             |                 | 62  | 75  | °C/W  |
| Maximum Junction-to-Lead <sup>C</sup>    | $R_{\theta JL}$ | 18  | 24  | °C/W  |

**Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions  | Min | Typ  | Max    | Units            |
|-----------------------------|---------------------------------------|---|-----|------|--------|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |   |     |      |        |                  |
| $\text{BV}_{\text{DSS}}$    | Drain-Source Breakdown Voltage        | $I_D=250\mu\text{A}, V_{GS}=0\text{V}$                                      | 30  |      |        | V                |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=30\text{V}, V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$             |     |      | 1<br>5 | $\mu\text{A}$    |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}, V_{GS}=\pm 16\text{V}$                                   |     |      | 10     | $\mu\text{A}$    |
| $V_{GS(\text{th})}$         | Gate Threshold Voltage                | $V_{DS}=V_{GS}, I_D=250\mu\text{A}$   | 1.4 | 1.8  | 2.5    | V                |
| $I_{D(\text{ON})}$          | On state drain current                | $V_{GS}=10\text{V}, V_{DS}=5\text{V}$                                       | 120 |      |        | A                |
| $R_{DS(\text{ON})}$         | Static Drain-Source On-Resistance     | $V_{GS}=10\text{V}, I_D=16\text{A}$<br>$T_J=125^\circ\text{C}$              | 6   | 7.2  |        | $\text{m}\Omega$ |
|                             |                                       | $V_{GS}=4.5\text{V}, I_D=12\text{A}$  | 8   | 10   |        | $\text{m}\Omega$ |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=5\text{V}, I_D=16\text{A}$  |     | 55   |        | S                |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=1\text{A}, V_{GS}=0\text{V}$   |     | 0.70 | 1.0    | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |   |     |      | 4      | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |   |     |      |        |                  |
| $C_{iss}$                   | Input Capacitance                     | $V_{GS}=0\text{V}, V_{DS}=15\text{V}, f=1\text{MHz}$                        |     | 1803 | 2170   | pF               |
| $C_{oss}$                   | Output Capacitance                    |   |     | 387  |        | pF               |
| $C_{rss}$                   | Reverse Transfer Capacitance          |   |     | 238  |        | pF               |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$                         |     | 1.3  | 2      | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |   |     |      |        |                  |
| $Q_g(10\text{V})$           | Total Gate Charge                     | $V_{GS}=10\text{V}, V_{DS}=15\text{V}, I_D=16\text{A}$                      |     | 36   | 48     | nC               |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     |   |     | 19   |        | nC               |
| $Q_{gs}$                    | Gate Source Charge                    |   |     | 3.9  |        | nC               |
| $Q_{gd}$                    | Gate Drain Charge                     |   |     | 8.7  |        | nC               |
| $t_{D(\text{on})}$          | Turn-On Delay Time                    | $V_{GS}=10\text{V}, V_{DS}=15\text{V}, R_L=1\Omega, R_{\text{GEN}}=3\Omega$ |     | 7.6  |        | ns               |
| $t_r$                       | Turn-On Rise Time                     |   |     | 6.4  |        | ns               |
| $t_{D(\text{off})}$         | Turn-Off Delay Time                   |   |     | 27   |        | ns               |
| $t_f$                       | Turn-Off Fall Time                    |   |     | 8.5  |        | ns               |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=16\text{A}, dI/dt=100\text{A}/\mu\text{s}$                             |     | 27   | 33     | ns               |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=16\text{A}, dI/dt=100\text{A}/\mu\text{s}$                             |     | 17   |        | nC               |

A: The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B: Repetitive rating, pulse width limited by junction temperature.

C. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using <300  $\mu\text{s}$  pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The SOA curve provides a single pulse rating.

F. The current rating is based on the  $t \leq 10\text{s}$  thermal resistance rating.

G. EAR and IAR ratings are based on low frequency and duty cycles such that  $T_j(\text{start})=25^\circ\text{C}$  for each pulse.

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## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

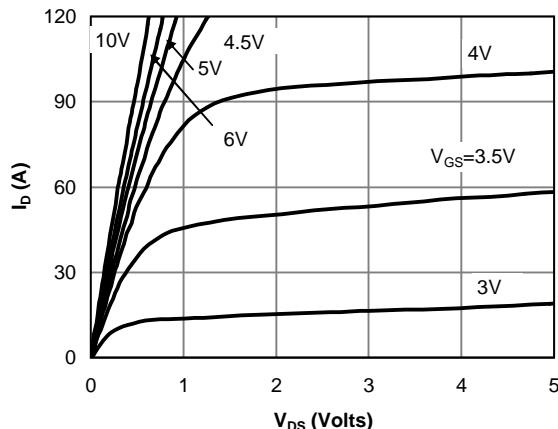


Figure 1: On-Region Characteristics

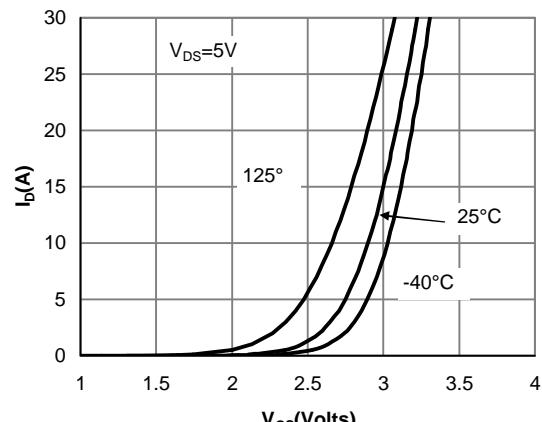


Figure 2: Transfer Characteristics

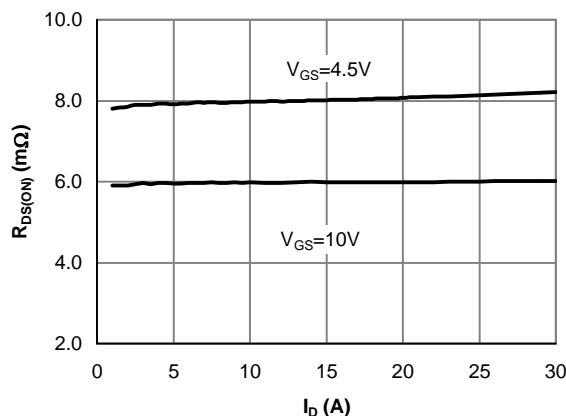


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

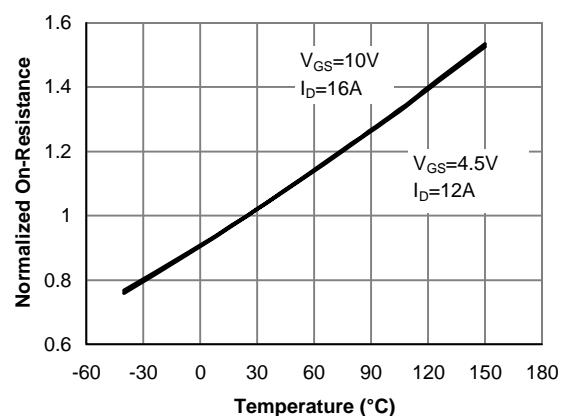


Figure 4: On-Resistance vs. Junction Temperature

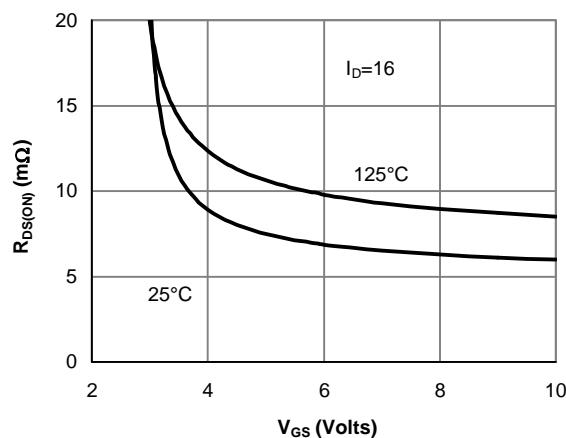


Figure 5: On-Resistance vs. Gate-Source Voltage

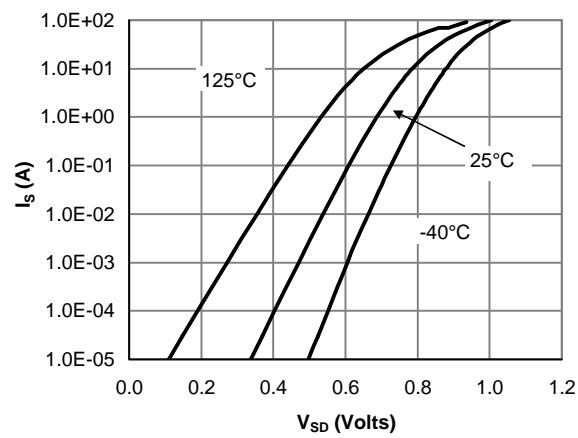


Figure 6: Body-Diode Characteristics

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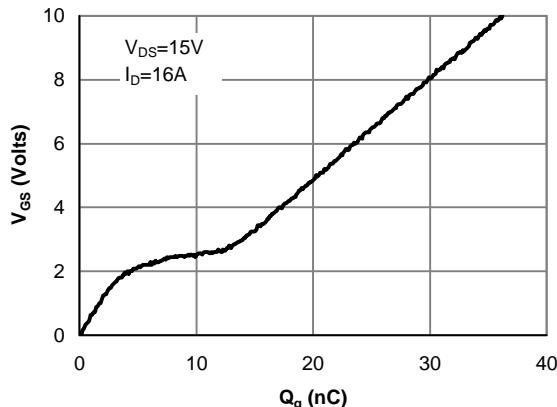


Figure 7: Gate-Charge Characteristics

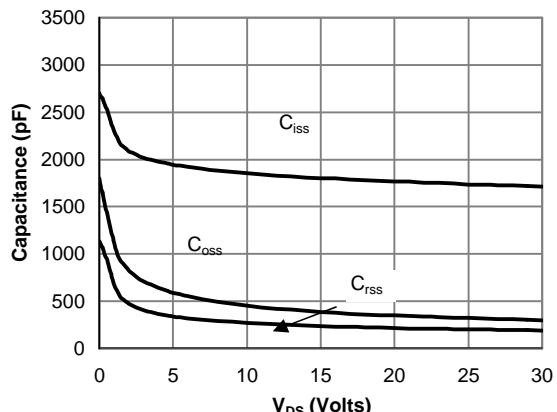


Figure 8: Capacitance Characteristics

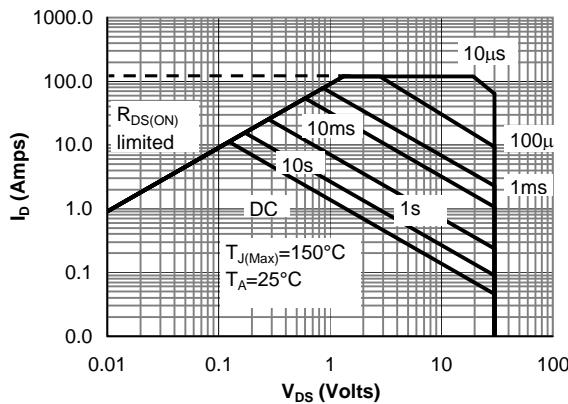


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

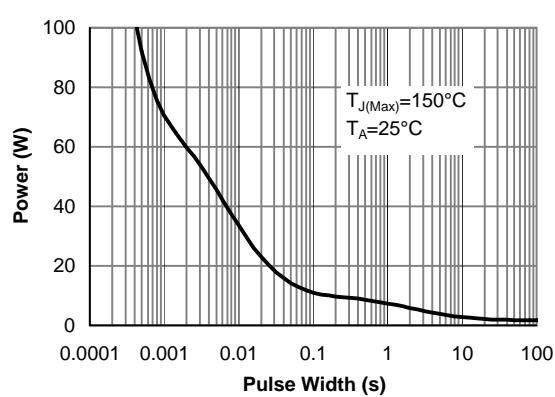


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

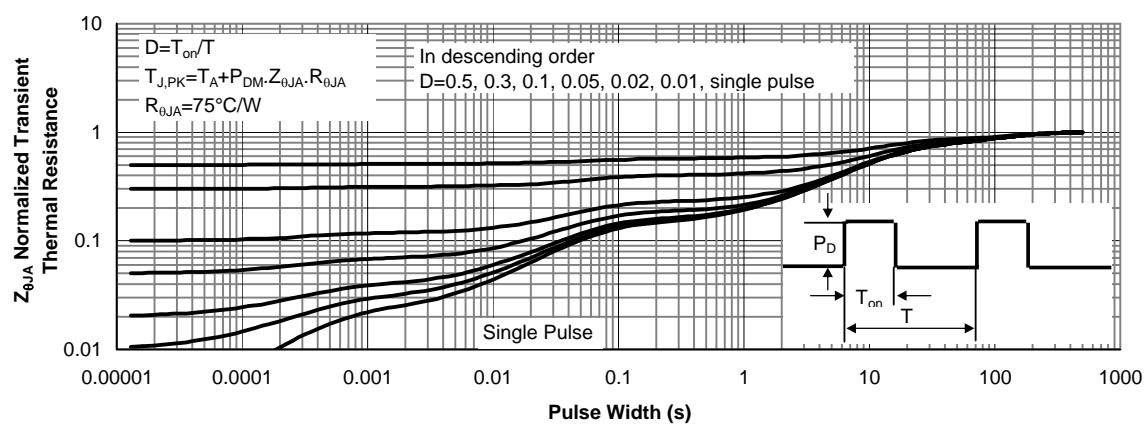


Figure 11: Normalized Maximum Transient Thermal Impedance (Note E)

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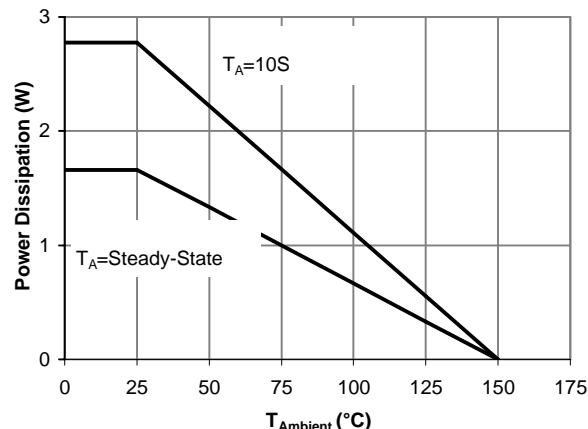
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

Figure 12: Power De-rating (Note A)